

<b>Notice of References Cited</b>	Application/Control No. 10/780,415		Applicant(s)/Patent Under Reexamination SUN ET AL.	
	Examiner Robert Shiao		Art Unit 1626	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,566,387	05-2003	Palovich et al.	514/401
*	C	US-6,897,225	05-2005	Sircar et al.	514/333
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N	WO00/72845	12-2000	WO	PaLOVICH ET AL.	-----
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**NON-PATENT DOCUMENTS**

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	U	Issartel et al., 1996, CAS: 125:316198.
	V	Palovich et al., 2000, CAS: 134:25357.
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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